- Designed Specifically for High-Speed Memory Decoders and Data Transmission Systems
- Incorporates Three Enable Inputs to Simplify Cascading and/or Data Reception
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin $V_{C C}$ and GND Configurations Minimize High-Speed Switching Noise
- EPIC ${ }^{m}$ (Enhanced-Performance Implanted CMOS) 1- $\mu \mathrm{m}$ Process
- 650-mA Typical Latch-Up Immunity at $125^{\circ} \mathrm{C}$
- Package Options Include Plastic Small-Outline Packages, Plastic Thin Shrink Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs


## description

The 'ACT11138 circuit is designed to be used in high-performance memory-decoding or datarouting applications requiring very short propagation delay times. In high-performance memory systems, this decoder can be used to minimize the effects of system decoding. When employed with high-speed memories utilizing a fast enable circuit, the delay times of this decoder and the enable time of the memory are usually less than the typical access time of the memory. This means that the effective system delay introduced by the decoder is negligible.
The conditions at the binary select inputs and the three enable inputs select one of eight input lines. Two active-low and one active-high enable inputs reduce the need for external gates or inverters when expanding. A 24 -line decoder can be implemented without external inverters and a 32 -line decoder requires only one inverter. An enable input can be used as a data input for demultiplexing applications.
The 54ACT 11138 is characterized for operation over the full military temperature range of $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$. The 74 ACT 11138 is characterized for operation from $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$.

## 3-LINE TO 8-LINE DECODERS/DEMULTIPLEXERS

SCAS050A - D3266, JANUARY 1989 - REVISED APRIL 1993
logic symbols (alternatives) $\dagger$

$\dagger$ These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the $\mathrm{D}, \mathrm{J}$, and N packages.
logic diagram (positive logic)


Pin numbers shown are for the $\mathrm{D}, \mathrm{J}$, and N packages.

FUNCTION TABLE

| ENABLE <br> INPUTS |  |  | SELECT <br> INPUTS |  |  |  |  |  | OUTPUTS |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| G1 | G2A | G2B | C | B | A | Y0 | Y1 | Y2 | Y3 | Y4 | Y5 | Y6 | Y7 |
| X | H | X | X | X | X | H | H | H | H | H | H | H | H |
| X | X | H | X | X | X | H | H | H | H | H | H | H | H |
| L | X | X | X | X | X | H | H | H | H | H | H | H | H |
| H | L | L | L | L | L | L | H | H | H | H | H | H | H |
| H | L | L | L | L | H | H | L | H | H | H | H | H | H |
| H | L | L | L | H | L | H | H | L | H | H | H | H | H |
| H | L | L | L | H | H | H | H | H | L | H | H | H | H |
| H | L | L | H | L | L | H | H | H | H | L | H | H | H |
| H | L | L | H | L | H | H | H | H | H | H | L | H | H |
| H | L | L | H | H | L | H | H | H | H | H | H | L | H |

absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$
Supply voltage range, $\mathrm{V}_{\mathrm{CC}}$
-0.5 V to 7 V
Input voltage range, $\mathrm{V}_{\mathrm{I}}$ (see Note 1) .................................................... 0.5 V to $\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$





Storage temperature range $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
recommended operating conditions

|  |  | 54ACT11138 |  | 74ACT11138 |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | MAX | MIN | MAX |  |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage | 4.5 | 5.5 | 4.5 | 5.5 | V |
| $\mathrm{V}_{\text {IH }}$ | High-level input voltage | 2 |  | 2 |  | V |
| $\mathrm{V}_{\text {IL }}$ | Low-level input voltage |  | 0.8 |  | 0.8 | V |
| $V_{1}$ | Input voltage | 0 | $\mathrm{V}_{\mathrm{CC}}$ | 0 | $\mathrm{V}_{\mathrm{CC}}$ | V |
| $\mathrm{V}_{\mathrm{O}}$ | Output voltage | 0 | $\mathrm{V}_{\mathrm{CC}}$ | 0 | $\mathrm{V}_{\mathrm{CC}}$ | V |
| $\mathrm{IOH}^{\text {O }}$ | High-level output current |  | -24 |  | -24 | mA |
| l OL | Low-level output current |  | 24 |  | 24 | mA |
| $\Delta \mathrm{t} / \Delta \mathrm{v}$ | Input transition rise or fall rate | 0 | 10 | 0 | 10 | ns/V |
| $\mathrm{T}_{\text {A }}$ | Operating free-air temperature | -55 | 125 | -40 | 85 | ${ }^{\circ} \mathrm{C}$ |

## 3-LINE TO 8-LINE DECODERS/DEMULTIPLEXERS

SCAS050A - D3266, JANUARY 1989 - REVISED APRIL 1993
electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

$\dagger$ Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms .
$\ddagger$ This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or $\mathrm{V}_{\mathrm{CC}}$.
switching characteristics over recommended ranges of supply voltage and free-air temperature (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  | 54ACT11138 |  | 74ACT11138 |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP | MAX | MIN | MAX | MIN | MAX |  |
| tPLH | A, B, C | Any Y | 1.5 | 6.1 | 8.9 | 1.5 | 10.5 | 1.5 | 9.8 | ns |
| tPHL |  |  | 1.5 | 6 | 8.7 | 1.5 | 10.3 | 1.5 | 9.7 |  |
| tPLH | G1 | Y | 1.5 | 5.5 | 8 | 1.5 | 9.4 | 1.5 | 8.9 | ns |
| tPHL |  |  | 1.5 | 6 | 7.9 | 1.5 | 9.5 | 1.5 | 8.9 |  |
| tPLH | $\overline{\mathrm{G} 2 \mathrm{~A}}, \overline{\mathrm{G} 2 \mathrm{~B}}$ | Any Y | 1.5 | 6.4 | 8.3 | 1.5 | 9.9 | 1.5 | 9.3 | ns |
| tPHL |  |  | 1.5 | 6 | 8.8 | 1.5 | 10.5 | 1.5 | 9.8 |  |

operating characteristics, $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$

|  | PARAMETER | TEST CONDITIONS | TYP | UNIT |
| :--- | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {pd }}$ | Power dissipation capacitance | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \quad \mathrm{f}=1 \mathrm{MHz}$ | 88 | pF |

## PARAMETER MEASUREMENT INFORMATION



NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. Input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}}=3 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}}=3 \mathrm{~ns}$.
C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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